

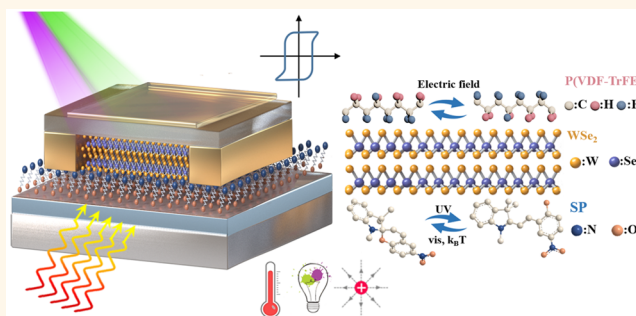
Asymmetric Dressing of WSe₂ with (Macro)molecular Switches: Fabrication of Quaternary-Responsive Transistors

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ABSTRACT: The forthcoming saturation of Moore's law has led to a strong demand for integrating analogue functionalities within semiconductor-based devices. As a step toward this goal, we fabricate quaternary-responsive WSe₂-based field-effect transistors (FETs) whose output current can be remotely and reversibly controlled by light, heat, and electric field. A photochromic silane-terminated spiropyran (SP) is chemisorbed on SiO₂ forming a self-assembled monolayer (SAM) that can switch from the SP to the merocyanine (MC) form in response to UV illumination and switch back by either heat or visible illumination. Such a SAM is incorporated at the dielectric–semiconductor interface in WSe₂-based FETs.

Upon UV irradiation, a drastic decrease in the output current of 82% is observed and ascribed to the zwitterionic MC isomer acting as charge scattering site. To provide an additional functionality, the WSe₂ top surface is coated with a ferroelectric *co*-polymer layer based on poly(vinylidene fluoride-*co*-trifluoroethylene). Because of its switchable inherent electrical polarization, it can promote either the accumulation or depletion of charge carriers in the WSe₂ channel, thereby inducing a current modulation with 99% efficiency. Thanks to the efficient tuning induced by the two components and their synergistic effects, the device polarity could be modulated from *n*-type to *p*-type. Such a control over the carrier concentration and device polarity is key to develop 2D advanced electronics. Moreover, the integration strategy of multiple stimuli-responsive elements into a single FET allows us to greatly enrich its functionality, thereby promoting the development for More-than-Moore technology.

KEYWORDS: 2D semiconductors, spiropyran, multistimuli-responsive, photochromic, thermochromic, ferroelectric



Taking advantage of their extraordinary physicochemical properties and compatibility with silicon-based technology, two-dimensional materials (2DMs), including graphene and transition-metal dichalcogenides, have been the target of extensive fundamental studies and technological progress over the past decade.^{1–3} In the current More-than-Moore era, the construction of multifunctional and multi-responsive 2DM-based devices is being explored. Owing to their atomic thickness and reduced screening effects, the intrinsic properties of 2DMs are extremely sensitive to the external environment and can be modulated by surface modification.⁴ Various organic molecules have already been embedded into 2DM-based electronic devices (*e.g.*, transistors) as a mean to finely adjust their electrical characteristics, mainly *via* doping.^{5–7} In addition, during the last five years considerable efforts have been dedicated to the incorporation of stimuli-responsive molecules, which are able to undergo precise nanoscale rearrangements in response to chemical or

physical inputs, as fundamental building blocks in conventional electronic devices.⁸ Upon integration of such dynamic molecular systems, the external stimuli may act as an additional remote control to operate the target devices, endowing them with *ad hoc* properties for specific applications such as memories,^{9,10} UV sensors,^{11,12} synapse simulation,^{13,14} and so on.

Light and electric field recently emerged as attractive external stimuli, both of which are noninvasive, remotely and digitally controllable with high spatial and temporal

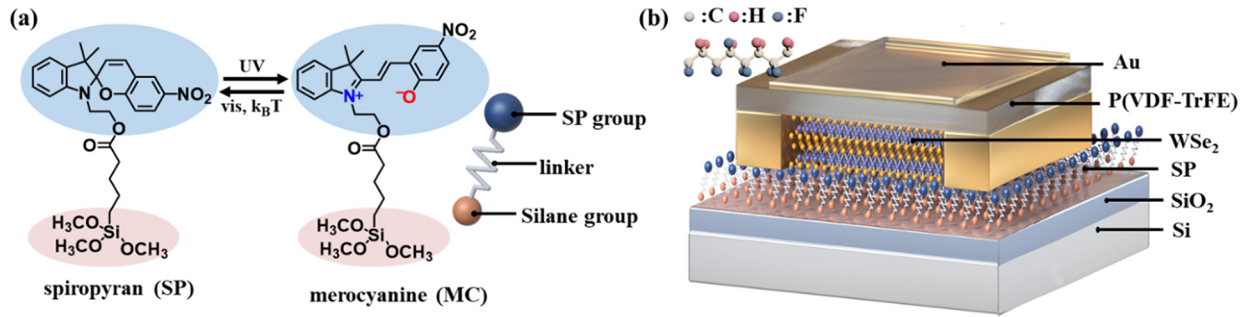


Figure 1. (a) Structure formulas of SP and MC and scheme of the SP–MC reversible isomerization obtained upon irradiation with UV ($\lambda = 365$ nm) and vis ($\lambda = 530$ nm) light, respectively. (b) Schematic illustration of the Janus SP/WSe₂/P(VDF-TrFE) FET device with double-sided decoration: the bottom surface of WSe₂ is functionalized with SP SAM and the top surface is functionalized with a P(VDF-TrFE) layer.

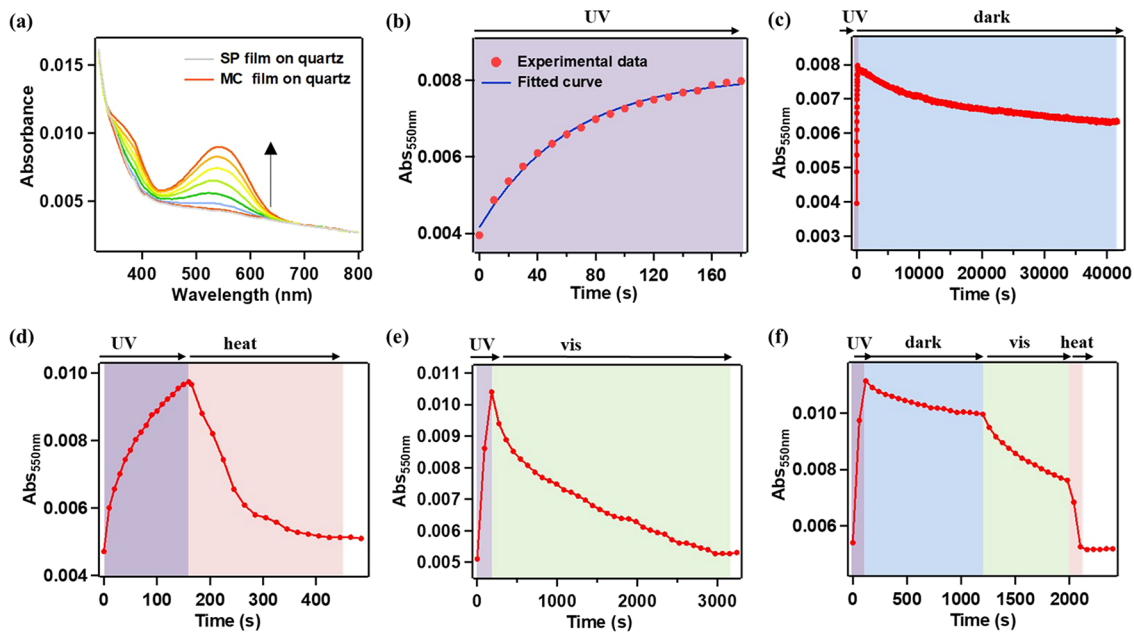


Figure 2. Optical characterization of the SP SAM photoisomerization on quartz substrate by UV–vis absorption spectroscopy. (a) Absorption spectral variation of SP SAM during the course of UV irradiation at 365 nm until reaching the photostationary state (PSS). (b–f) Kinetics of the SP SAM isomerization, monitored by plotting the absorbance at 550 nm under various conditions: (b) UV irradiation, (c) dark at room temperature, (d) dark upon heating at *ca.* 80 °C, (e) vis irradiation at 530 nm, (f) combination of dark, vis irradiation, and heat.

resolution.¹⁵ As a mild and easy-to-use stimulus, temperature also represents one of the most widely explored inputs in the design of stimuli-responsive platforms.

Triggered by light, the isomerization of photochromic molecules has been demonstrated to be a simple-but-effective strategy to implement the optical switching in the manipulation of charge carrier transport in 2DM-based FETs.¹⁶ We recently reported the successful fabrication of optically switchable FETs based on the physisorption of a top layer of diarylethenes,^{17,18} azobenzene^{19–22} or spiropyran (SP)^{23–26} onto the 2D channel material, demonstrating a reversible control over the output current as a result of the molecular photoisomerization. On the other hand, an external electric field was used to control the intrinsic bistable polarization of ferroelectric macromolecules, such as the ferroelectric *co*-polymer poly(vinylidene fluoride-*co*-trifluoroethylene), P-(VDF-TrFE), when interfaced to 2DMs, as a means to reversibly modulate the doping level^{27,28} and device current output according to the direction of its polarization.^{29–31}

In this paper, we upgrade such stimuli-responsive 2DM-based FETs to a higher level by “dressing” the two surfaces of the ultrathin channel materials in an asymmetric manner, yielding a Janus structure. This enables the incorporation of a third component into the device geometry, where the bottom and the top surface of the 2DM interact with different functional molecules. The presence of more than one stimuli-responsive function in the FET imparts to the device an overall multistimuli-responsive character. To enhance the robustness of the photochromic layer and to make it compatible with standard photolithography processes for optoelectronic device fabrication, the chemisorption of a SP derivative bearing an organosilane moiety capable to bind the Si/SiO₂ substrate and form a self-assembled monolayer (SAM) is utilized to incorporate such a functional molecule at the dielectric-semiconductor interface.³² This chemisorption approach facilitates the device fabrication and provides a better compatibility when integrating a third responsive element into the system.

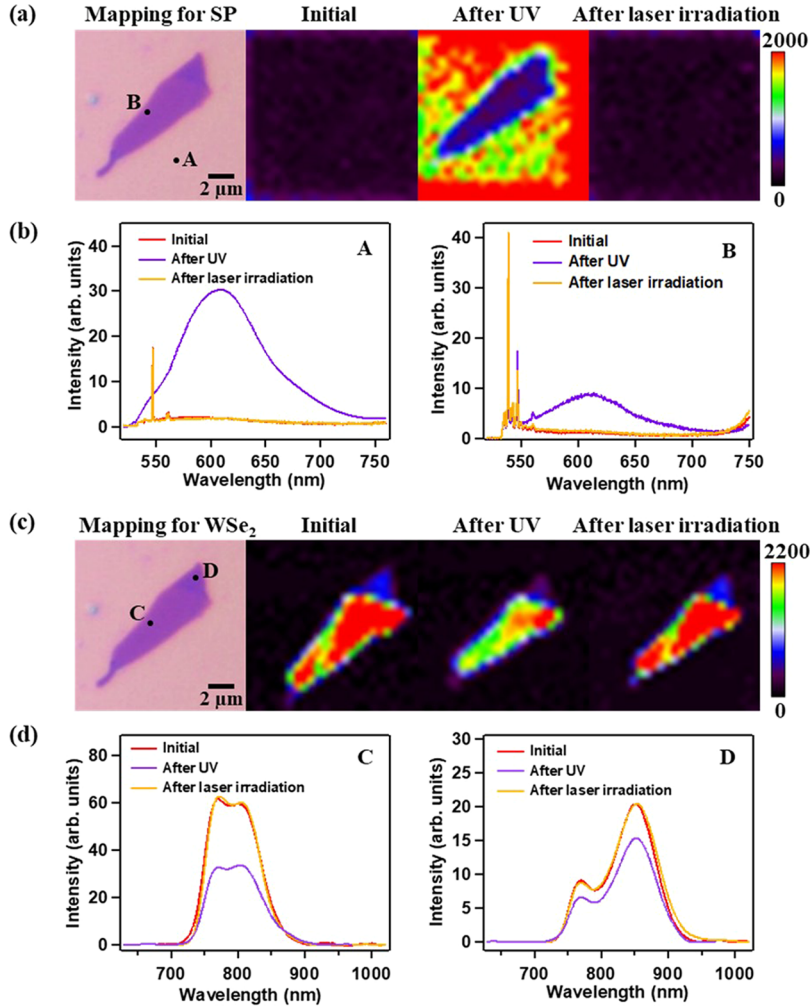


Figure 3. (a) Optical microscopy image of a SP/WSe₂ flake (left) and its PL intensity mapping (right) recorded from 560 to 650 nm in initial, after UV irradiation, and after laser irradiation condition. (b) PL spectra evolution in the points A and B. (c) Same flake with PL intensity mapping recorded from 750 to 900 nm in initial, after UV irradiation, and after laser irradiation condition. (d) PL spectra evolution in the points C (bilayer) and D (few-layer). For all PL measurements, $\lambda_{\text{exc}} = 532$ nm.

Here, we sandwich few-layer thick WSe₂ flakes in between a SAM of SP molecules chemisorbed on Si/SiO₂ substrate and a top coating layer of the ferroelectric *co*-polymer P(VDF-TrFE). The photoisomerization reaction from SP to MC can be triggered by UV irradiation, while the reverse isomerization from MC to SP can be accomplished by visible (*vis*) irradiation as well as heating,³³ adding a further thermal-responsive nature to the related FET devices. Therefore, such a vertically asymmetric architecture enables an independent control of the output current under the effect of distinct multiple inputs, yielding quaternary-stimuli-responsive FETs capable of responding to heat, light, and electric field. The electron current modulation efficiency reaches 84% for SP photoisomerization and 99% for P(VDF-TrFE) polarization. Moreover, taking advantage of the synergistic effect between the two stimuli, the electrons in the channel can be totally depleted when combining them into a single switch and the device polarity can be modulated from *n*-type to *p*-type. Furthermore, by collecting a pool of multiple stimuli as inputs, the overreliance upon a single stimulus has been reduced, increasing the sensitivity and compliance of the molecular-tailored stimuli-responsive platform.

RESULTS AND DISCUSSION

The synthesis of the silane-terminated SP derivative and the protocol of SP SAM functionalization of SiO₂ is provided in the [Experimental Methods](#) and in the Supporting Information ([Scheme S1](#), [Figures S1–S5](#)). The reversible photoisomerization between SP and MC is schematically illustrated in [Figure 1a](#). The successful functionalization of SP SAM on SiO₂ surface was confirmed through UV–*vis* absorption spectra ([Figure 1](#), [Figures S6 and S7](#)), water contact angle measurements ([Figure S8](#)), atomic force microscopy (AFM) ([Figure S9](#)) and photoluminescence (PL) mapping ([Figure 2](#), [Figures S10 and S11](#)).

UV–*vis* absorption spectra of SP SAM on quartz substrate were initially recorded during the exposure to UV irradiation ([Figure 2a](#)). The typical band of MC chromophores centered at 550 nm appeared after few seconds of UV irradiation. Therefore, the kinetics of the photoisomerization between SP and MC could be followed by monitoring the evolution of the absorbance at 550 nm ($Abs_{550 \text{ nm}}$). $Abs_{550 \text{ nm}}$ kept rising upon irradiation with UV light until the photostationary state (PSS) was reached after 180 s, the trend of which can be fitted with a simple monoexponential equation ([Figure 2b](#), [Table S1](#)).²⁴ Note that the saturation time of SP to MC transition is

dependent on the intensity of UV illumination, as shown in Figure S7. Being photochromic and thermochromic, the MC isomer can be switched back to SP by either thermal treatment or vis irradiation, showing a decrease of $Abs_{550\text{ nm}}$ in accordance with a first-order decay (Figure S6). At room temperature, ca. 37.5% of the molecules in the MC form were transformed to SP after 11 h (Figure 2c). This process can be accelerated by heating at ca. 80 °C, with a kinetic that requires only 4 min (Figure 2d) for the complete conversion of MC to SP. Irradiation with vis light for ca. 45 min enabled to convert all the MC into SP (Figure 2e). Finally, when the 3 treatments were combined together within the same experiment, different kinetics could be clearly singled out (Figure 2f). The different kinetics can be explained considering that the thermal and photochemical isomerization of MC to SP follows different reaction mechanisms.^{34,35}

Water contact angle measurements of unmodified Si/SiO₂, pristine SP SAMs, and UV/heat-treated SP SAMs on Si/SiO₂ surfaces are displayed in Figures S8. The unmodified Si/SiO₂ surface displayed a hydrophilic behavior ($33.6 \pm 0.3^\circ$). Upon SP functionalization the hydrophobicity of the surface increased ($73.8 \pm 0.6^\circ$). When irradiated with UV light, the contact angle of such a surface showed a decrease by 15.2° , indicating a higher hydrophilicity of the surface. This can be explained by the higher polarity of the zwitterionic MC compared to SP,³³ thus leading to an increase in the wettability of the surface. The initial values could be recovered by following heating, confirming the reversible nature of the SP–MC isomerization.

The morphology of the SP SAM was investigated by AFM (Figure S9). The imaging performed on SP-functionalized SiO₂ surface revealed a rather flat morphology, with a root-mean-square roughness (R_{RMS}), determined over an area of $1\ \mu\text{m} \times 1\ \mu\text{m}$, corresponding to ca. 0.45 nm. For the sake of comparison, the morphology on unmodified Si/SiO₂ surface was found being smoother with a R_{RMS} amounting to ca. 0.16 nm. As estimated by topographical profile, the height of the features displayed by the SP-functionalized SiO₂ surface was $1.3 \pm 0.5\ \text{nm}$. We ascribe the presence of such features to aggregates of SP on top of the SP SAM. The appearance of such aggregates is likely due to polymerization of the silane-terminated SP that could not be washed away after the treatment.³⁶

The WSe₂ flakes were transferred on top of the SP-functionalized SiO₂ substrate by using the conventional scotch-tape approach. To unveil the interaction between SP and WSe₂, 2D mapping of photoluminescence (PL) intensity was carried out over WSe₂ flakes with different thickness by using an optical microscope equipped with a spectrometer and a 532 nm laser line. The PL evolution of the SP/MC molecules was first investigated by exploring the wavelength range from 560 to 650 nm in which MC is luminescent, while SP is not. As illustrated in Figure 3a, the as prepared SP/WSe₂ was found to be scarcely photoluminescent. After UV illumination, the PL intensity in the regions that were not covered by the flake strongly increased, corroborating an effective SP to MC isomerization. Interestingly, the region covered by the flake showed a weaker PL, which can be ascribed to the quenching effect by WSe₂. Note that a relatively low laser power (0.03 mW) was used during the measurement in order to minimize the occurrence of the MC → SP photoisomerization. In order to switch the molecules back to SP form, a higher laser power (4.92 mW) was utilized to scan the same region. Figure 3a

clearly shows that the PL, after laser scanning, was restored to the original state, providing evidence for the recovery of SP. Figure 3b depicts the detailed PL spectra evolution in the points labeled as A and B. Note that some spikes emerged around 550 nm, which can be attributed to the Raman signals of both silicon substrate and SP/MC.³⁷ To investigate if the SP photoswitch also involves a modulation of the optical properties of the 2DM, we measured the PL of WSe₂ in the wavelength range from 750 to 900 nm. The PL spectra recorded on a bilayer (highlighted in C) and a few-layer (highlighted in D) region of a WSe₂ flake are shown in Figure 3c,d (some spatial variations in the PL intensity were observed due to the different flake thickness). The bilayer region presents PL spectra with a broad band corresponding to the emission from both the indirect and direct bandgaps.³⁸ Conversely, the few-layer region exhibits a strikingly decreased emission intensity compared to the thinner region, and the PL spectra contain two distinct peaks due to the indirect and direct bandgaps emission, as well.³⁸ It is worth mentioning that these two regions provided identical results: an overall quenching of the PL intensity for WSe₂ was observed when molecules were switched to the MC form, which can be completely restored by laser irradiation to switch the molecules back to SP form, providing evidence of the electronic interaction between these two components. Importantly, when then same experimental procedure was repeated on flakes with different thickness, it returned the same PL intensity evolution behavior, thus confirming the reproducibility of such an evolution (Figures S10 and S11). We ascribe the variation of the PL properties of WSe₂ to the change in dipole moment of the underlying SAM upon isomerization from SP to MC. In fact, ring-closed SP isomer is neutral and has low molecular dipole moment ($\mu \sim 4\text{--}6\ \text{D}$) compared to the ring-open MC isomer. The latter is the hybrid between a quinoidal and zwitterionic form, characterized by a higher molecular dipole moment ($\mu \sim 14\text{--}18\ \text{D}$).³³ The charges related to zwitterionic MC may quench the PL *via* enhanced nonradiative Auger recombination, in agreement with previous works.¹¹

To cast light onto the electrical properties of the SP/WSe₂ hybrid, it has been integrated as channel material into FETs. The devices revealed an *n*-type behavior with electron mobility of $12.4\ \text{cm}^2\ \text{V}^{-1}\ \text{s}^{-1}$, which is typical for back-gated WSe₂ FETs with nine atomic layers (Figure S12).³⁹ Interestingly, upon UV light irradiation to PSS condition, the device showed a major decrease of electron current, with a modulation efficiency of 82% and ultimate mobility up to $1.1\ \text{cm}^2\ \text{V}^{-1}\ \text{s}^{-1}$. Upon heating, the current was restored almost to the initial value, in accordance with the reversible change in the absorption spectra and PL mapping.

Inspired by our recent work on the dual functionalization of WSe₂ with a ferroelectric *co*-polymer and a physisorbed photochromic diarylethenes layer to achieve ternary switchable field-effect transistors,⁴⁰ in order to add an additional functionality to the as-fabricated optically switchable SP/WSe₂ FET devices, the upper surface of WSe₂ flakes was dressed with a 580 nm-thick layer of ferroelectric *co*-polymer based on poly(vinylidene fluoride-*co*-trifluoroethylene)-P-(VDF-TrFE) (Figure S13), followed by the deposition of a semitransparent top-gate electrode (20 nm thick Au layer). Note that such a thickness of P(VDF-TrFE) is required to guarantee a high device's success rate during the fabrication, in agreement with previous reports.^{41,42} By applying a voltage to

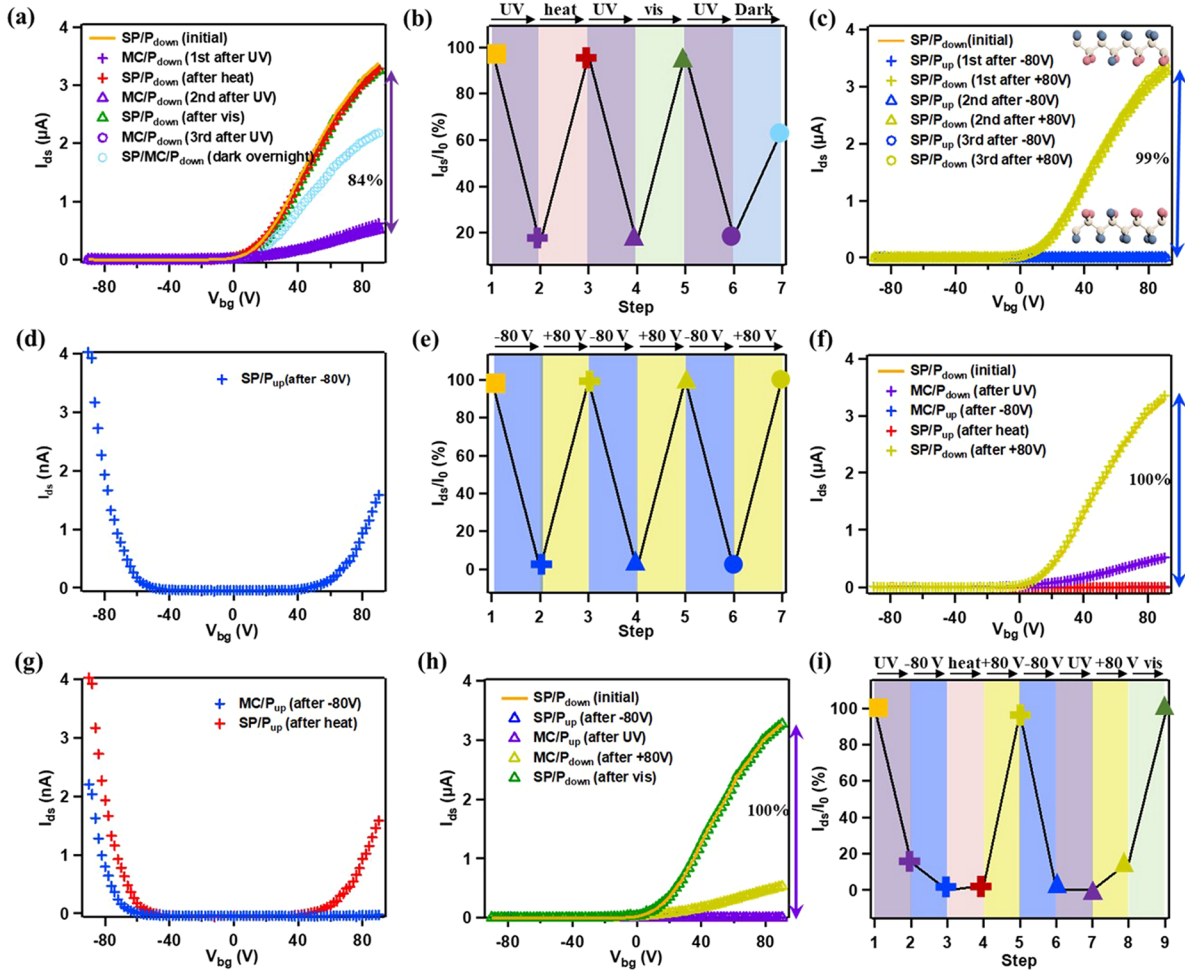


Figure 4. Electrical characterization of SP/WSe₂/P(VDF-TrFE) FET. (a) Optical/thermal switching by UV and heat/vis/dark treatment. (b) Current modulation efficiency at $V_{bg} = 90$ V during three switching cycles in (a). (c) Electrical switching by ± 80 V top-gate bias. (d) Transfer curve of SP/P_{up} state in (c). (e) Current modulation efficiency at $V_{bg} = 90$ V during the three switching cycles in (c). (f) Orthogonal switching with the stimuli order of UV/ -80 V/heat/ $+80$ V. (g) Transfer curves of MC/P_{up} state and SP/P_{up} state in (f). (h) Orthogonal switching with the order of -80 V/UV/ $+80$ V/vis. (i) Current modulation efficiency at $V_{bg} = 90$ V during the two switching cycles in (f) and (h).

the upper Au electrode, a control over the polarization direction of the P(VDF-TrFE) layer becomes possible (Figure S14). Figure 1b displays a schematic view of the SP/WSe₂/P(VDF-TrFE) FET. First, the device properties in top-gate configuration with P(VDF-TrFE) serving as dielectric material were investigated (Figure S15a), revealing an electron transport-dominated ambipolar behavior. The corresponding leakage current is reported in Figure S15b, with two apparent current peaks near the coercive field of P(VDF-TrFE), proving its good dielectric and ferroelectric characteristics.

The optical/heating switching capabilities of SP/WSe₂/P(VDF-TrFE) FET were investigated in a back-gate device configuration (Figure 4a,b). With its dielectric constant ($\epsilon_r = 10$) being higher than that of SiO₂ ($\epsilon_r = 3.9$), P(VDF-TrFE) can suppress the Coulomb scattering in WSe₂.² As a consequence, an improved electron mobility ($18.2 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$) was observed in SP/WSe₂/P(VDF-TrFE) FET compared to above SP/WSe₂ FET ($12.4 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$). In response to UV irradiation to PSS conditions, the electron current notably decreased with a modulation efficiency of 84%, along with a decrease of field-effect mobility up to $2.6 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$. Figure 4b depicts the reversible variation of the current during three

cycles when different inputs were used to switch back the molecules to SP form: heating, vis irradiation and thermally at room temperature. By heating at 80°C for 10 min or vis irradiation at 530 nm for 30 min, the effects of the previous UV irradiation could be completely removed, and the electrical performance was restored to the original state. Conversely, by leaving the previously UV irradiated device overnight in dark and at room temperature, only 63% of the initial current was restored. Importantly, such kinetics information from electrical characterization matched the UV-vis absorption results reported above.

We also explored the reversibility of device performance when P(VDF-TrFE) exhibits upward or downward polarization directions (Figure 4c-e). When a -80 V pulse was applied to the top-gate electrode, dipoles inside P(VDF-TrFE) were aligned along the external electric field in the upward direction with negatively charged C-F bond facing the channel, causing the pronounced depletion of electrons and accumulation of holes. The corresponding schematic representation of the polarization direction is given in Figure 4c. Therefore, compared to the pristine state (orange line), there was a dramatic decrease of electron current, with an efficiency

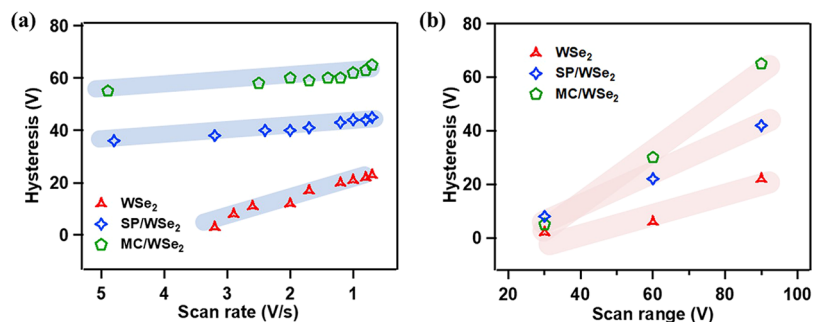


Figure 5. Hysteresis characterization. (a,b) Hysteresis comparison of FETs based on bare WSe_2 , SP/WSe_2 and MC/WSe_2 under (a) different scan rates and (b) different scan ranges.

as high as 99%, and a corresponding increase of hole current. The devices exhibited more balanced ambipolar behavior, with hole current comparable to the electron current ($\mu_{h+} = 0.118 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$, $\mu_{e-} = 0.024 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$), compared to the initial *n-type* dominant transport. On the contrary, a +80 V pulse led to a reversed arrangement of dipole moments in the downward polarization direction. In this case, with positively charged C–H bonds facing the channel, the current state resumed the original state. Such a reversible tuning could be repeated for at least three cycles without any attenuation upon the periodic +80 and –80 V bias operation.

To prove the compatibility between the two aforementioned switching elements, we combined light and electric bias stimuli in a single switching cycle. As shown in Figure 4f,g, upon UV irradiation, the device current decreased in the same ratio as the results above (*i.e.*, 84%). Interestingly, after being exposed to a subsequent negative top-gate bias, the devices showed a further electron current decrease, in combination with an increase of the hole current. Hence, the electrons in the channel were totally depleted and the device, in its final state, turned into *p-type* transport. Subsequent vis irradiation and positive bias led to the recovery of the original device performance. To further investigate our systems and prove the highest versatility in the use of different and independent inputs to modulate the device characteristics, the stimuli order was reversed in order to first polarize the P(VDF-TrFE) into the upward direction and then the SP molecules were switched into MC (Figure 4h). This experiment displayed identical results to the previous ones (Figure 4i), confirming that the two switching elements are able to work independently without mutual interference.

To better illustrate the current modulation in our SP/WSe_2 /P(VDF-TrFE) FETs achieved by different stimuli, dynamic current variation was tracked when the top-gate bias and light irradiation were supplied separately as input signals. As shown in Figure S16, when a negative bias was applied, the device current was greatly reduced and remained constant at that state. Then, in response to the applied positive bias, a current spike appeared, followed by the recovery of the original performance. The reversible current modulation confirmed the polarization of P(VDF-TrFE). Later, the UV irradiation triggered the photoisomerization of SP, thereby lowering the device current. Such a current modulation cycle can be operated at least five times, and a stepwise decay of current was clearly observed upon each cycle. These results further demonstrated that the SP/WSe_2 /(PVDF-TrFE) FET device is able to orthogonally respond to both external electric field and light irradiation.

Upon confirmation of successful photoswitching of the SAM at the interface between SiO_2 and active material, along with the consequent modulation in the electrical properties of our devices, we investigated the mechanism related to this phenomenon. We first hypothesized that electron transfer could occur between MC and WSe_2 . To analyze this possibility, we have evaluated the energy levels of WSe_2 and SP/MC. The conduction band (CB) and valence band (VB) of WSe_2 were calculated by screened exchange functional method,⁴³ and the highest occupied molecular orbital (HOMO) and lowest unoccupied molecular orbital (LUMO) energy levels of SP and MC were estimated by cyclic voltammetry (Figure S17). The energy level diagram is reported in Figure S18. Our devices based on few-layer WSe_2 displayed electron-dominant transport behavior, so we focused our attention on the CB of WSe_2 and the LUMO of SP/MC. Since the CB of WSe_2 is lower than the LUMO of both SP and MC isomer, electrons in WSe_2 can transfer to neither of these two isomers; hence the possibility for the MC molecules to act as electron trap sites can be excluded. On the other hand, when it comes to mono/bilayer WSe_2 which possesses hole-transport behavior, its VB and the HOMO of SP/MC should be taken into consideration. In this case, the HOMO of MC is slightly higher than the VB of WSe_2 , allowing the MC isomer to act as a shallow trap for holes, which might result in a drop of hole current in the corresponding devices. Electrical characterization of monolayer WSe_2 was presented in Figure S19, which shows a reversible hole current modulation. Although this mechanism can partially explain the hole current modulation induced by SP SAM, it does not explain the above observed significant electron transport modulation, therefore we tested the ionic impurity scattering mechanism as previously reported for analogous systems.⁴⁴ It is generally agreed that the charge carrier mobility/current of a semiconducting material is limited by the interfacial charged impurities, *i.e.* a lower current state is indicative of a higher density of charge scattering centers.⁴⁵ In our study, the SP isomer is neutral while the MC isomer is the hybrid between a quinoidal and zwitterionic form and has higher molecular dipole moment compared to SP. The high dipole moment MC isomers in the SAM may serve as scattering centers, inducing an attractive or repulsive force to the electrons flowing in the channel. Due to such Coulomb interactions, the ballistic acceleration of the flowing electrons in WSe_2 by the electric field is disturbed, resulting in a change of trajectory and gradually scattering, as well as leading to a decrease of the device current. Such a model is similar to that of Coulomb scattering by ionic impurities in semiconducting materials.⁴⁶

To confirm such a hypothesis, we investigated the hysteresis behavior in our devices by varying the gate sweep rate and the overall sweep range in bare WSe₂ FETs and SP/WSe₂ FETs, where the SP monolayer is either in the SP form or switched to MC in the UV PSS conditions (Figure S20). The hysteresis in the transfer characteristics of 2DM-based FET devices has been attributed to several mechanisms, such as adsorption of O₂ and H₂O molecules,^{47,48} gate-oxide⁴⁹ and oxide-TMD interface traps,⁵⁰ gate voltage stress,⁵¹ and intrinsic defects in the material.⁵² It is worth mentioning that in our system the only variable was represented by the photochromic layer, as the experimental conditions identical. A full gate sweep consists of both forward and backward sweeps, *i.e.*, from negative gate voltage (V_{bg}) to positive V_{bg} and then back to negative V_{bg} . A similar trend can be found for all of the measured devices: a hysteresis with clockwise loop direction, whose magnitude was tuned *via* both gate voltage sweep range and sweep rate. Figure 5a illustrates the comparison of the hysteresis for various sweep rates. In WSe₂ FETs, the hysteresis was relatively small, with significant dependence on the sweep rate: it increased from 3 at 3.2 V/s to 22 at 0.7 V/s. This is in accordance with previous reports, where faster sweep rates inhibit the electron trapping during the measurements.⁵³ Larger hysteresis was observed in SP/WSe₂ and MC/WSe₂, while the variation in magnitude with the sweep rate was minimal. Therefore, the main contribution to the hysteretic behavior can be ascribed to the SP/MC layer. Ionic impurity scattering is considered the main interaction between ionic adsorbates and the charge carriers in 2DMs. Moreover, it may alter the charge distribution at the interface between SiO₂ and 2DM due to the field induced polarization effect, considered one of the major sources of hysteresis in FET devices.^{54,55} When comparing the hysteresis in SP/WSe₂ and MC/WSe₂, a more pronounced magnitude was observed in the latter. Such a result matches our assumption for which the zwitterionic MC isomer behaves as major scattering center. Note that for better comparison of their hysteresis magnitude and current evolution efficiency transfer curves of SP/WSe₂ and MC/WSe₂ with the same scan rate have been plotted in Figure S21, both in logarithm and linear scale.

Besides the sweep rate, the hysteresis variations were also investigated within different sweep ranges (Figure S22). For WSe₂, the hysteresis was negligible in the sweep range of 30 V, and its magnitude increased as the range became wider. Such an observation indicates that hysteresis mainly originates from charge trapping/detrapping process at higher gate bias.⁵² When it comes to SP/WSe₂, the hysteresis variation became more prominent. These variations are plotted in Figure 5b, where molecules in MC form show a stronger sweep range dependent hysteresis variation compared to SP/WSe₂, thereby confirming that the MC isomer acts as ionic scattering center that plays a major role in the device performance.

CONCLUSIONS

In conclusion, we built quaternary-responsive WSe₂ FETs by asymmetrically dressing its bottom and top surface with light-responsive SP molecules and ferroelectric *co*-polymer P(VDF-TrFE), respectively. The output current of our SP/WSe₂/P(VDF-TrFE) FETs could be finely and independently modulated by external stimuli including heat, light irradiation, and electric field. It is worth mentioning that the synergistic effect between the different stimuli enables a significant modulation of the charge carrier transport within the channel,

switching from *n*-type to *p*-type with electrons being fully depleted. We also investigated the mechanism underlying the light induced transport modulation, highlighting how the zwitterionic MC isomer plays a major role as charge scattering center. Our design strategy of Janus modified structures *via* double-sided interfacial engineering can be extended to other 2DMs and to other stimuli, introduced by the use of suitably designed (macro)molecular components, therefore offering a general guideline for the fabrication of multifunctional and multiresponsive FET devices.

EXPERIMENTAL METHODS

Materials. WSe₂ crystals were purchased from HQ graphene. The P(VDF-TrFE) powder (with 70 mol % VDF) was purchased from Solvay. Si/SiO₂ n⁺ substrates with 270 nm thick oxide were purchased from Fraunhofer Institute for Photonic Microsystems IPMS. The quartz substrates with 2 mm thickness were purchased from Plan Optik.

Synthesis of Silane-Terminated SP Derivative. The synthetic strategy adopted for the preparation of the photochromic silane-terminated SP is reported in detail in the Supporting Information.

SP SAM Formation. The formation of SP SAM *via* silylation of hydroxyl functions on SiO₂ and quartz substrates with the photochromic silane SP is sketched in Figure S5. The substrates were initially cleaned in an ultrasonic bath in acetone and 2-propanol for 20 min, respectively. Then they were activated by exposing to UV/O₃ for 20 min to maximize the number of reactive hydroxyl groups on the surface. Afterward, the freshly UV/O₃ treated substrates were immediately immersed in an SP solution ($c = 3.6$ mM) in toluene. The solution was heated at 60 °C for 1 h and then left at room temperature overnight. Then the substrates were thoroughly rinsed with toluene and sonicated 5 s in hexane to remove the excess (unbound) SP. Finally, the substrates were baked at 60 °C for 1 h in order to polymerize the SP monolayer.

UV-vis Absorption Spectra. UV-vis absorption spectra and isomerization kinetics of the SP solution/SAM on quartz substrates were recorded at room temperature with a JASCO V650 spectrophotometer. The photoswitching experiments were performed with optical fiber-coupled LEDs (from ThorLabs) with wavelength of 365 nm (1.2 mW/cm²) or $\lambda = 530$ nm (4 mW/cm²). The switching by heating was performed using a heat gun set at *ca.* 80 °C. The PSS state is reached within 3 min of UV illumination. For SP solution, UV illumination intensities have been varied from 0.2 to 1 mW/cm² to examine the different saturation times of SP to MC transition. For SP SAM on quartz substrate, intensities have been varied from 0.4 to 1.9 mW/cm². For the photoisomerization kinetics, *in situ* irradiation was performed within the spectrophotometer chamber by shining UV/vis light on the quartz substrate using a custom-made setup. UV/vis irradiation was performed for fixed intervals, and Abs_{550 nm} was recorded immediately after switching off the light.

Water Contact Angle. The measurement was performed with a Krüss DSA 100 by deposition of a 2 μ L drop of Milli-Q water on unmodified Si/SiO₂, pristine SP SAMs, and UV/heat-treated SP SAMs on Si/SiO₂ surfaces. The UV illumination was performed with optical fiber-coupled LEDs (ThorLabs) with wavelength of 365 nm (1.2 mW/cm²) for 3 min. The heating was performed using a heat gun set at *ca.* 80 °C for 4 min. Note that each measurement was repeated three times and the average value was calculated.

AFM Imaging. The measurements were carried out using a Bruker Dimension Icon microscope in ambient conditions, operating in tapping mode and using TESPA-V2 tips with spring constant $k = 42$ N/m.

PL Mapping. The PL measurements were performed with a Renishaw InVia Raman microscope equipped with a 532 nm laser line. Each mapping was carried out with 0.5 mm steps in an area of 15 \times 15 mm². The spectra were recorded with 0.1 s of integration time and 1 accumulation under laser power of 0.03 mW. To switch the molecules from MC to SP form, the same area was scanned using the

same operating conditions and parameters but with a higher laser power (4.92 mW).

Device Fabrication and Characterization. After functionalizing the substrates with SP SAM, the mechanically exfoliated few-layer WSe₂ flakes were transferred onto the SP-decorated substrates. The source and drain electrodes were defined by Microtech laser writer equipped with a 405 nm laser. The AZ1505 photoresist and AZ326 MIF developer from MicroChemicals were used during the process. Then 60 nm Au was deposited onto the substrate followed by lift-off in warm acetone (*ca.* 55 °C). The P(VDF-TrFE) solution (10 wt % in butanol) was spin-coated on top of the SP/WSe₂ device (1000 rpm, 60 s), followed by annealing at 140 °C for 2 h on a hot plate in the nitrogen-filled glovebox to enhance its crystallinity. As verified by the transfer evolution of the SP/WSe₂ device before and after curing step (Figure S23), the SP modulation will not be deteriorated during such high-temperature annealing. Finally, a semitransparent top-gate electrode (20 nm Au) was evaporated on top of the P(VDF-TrFE) layer.

The electrical characterization was performed in the glovebox with a probe station connected to a Keithley 2636 sourcemeter. Light illumination for switching the SP was performed using an optical fiber-coupled monochromator (UV light at $\lambda = 365$ nm, $P_d = 3.2$ mW/cm² for 6 min to reach PSS or vis light at $\lambda = 530$ nm, $P_d = 11.8$ mW/cm² for 30 min to recover to SP). Heating for switching was performed using the hot plate at 80 °C for 10 min.

The charge carrier mobility is calculated in the saturation regime from the transfer curve by using the expression⁵⁶

$$\mu = \frac{dI_{ds}}{dV_g} \times \frac{L}{W} \times \frac{1}{V_{ds}} \times \frac{d}{\epsilon_0 \epsilon_r}$$

where L is the channel length, W is the channel width, and ϵ_r is the dielectric constant, $\epsilon_r = 3.9$ for SiO₂, and $\epsilon_r = 10$ for P(VDF-TrFE).

Thickness Determination. The thickness of the P(VDF-TrFE) layer was measured by a profilometer. The P(VDF-TrFE) layer was spin-coated to a clean Si/SiO₂ substrate, followed by 2 h annealing at 140 °C in the glovebox. Note that the layer preparation recipe kept the same as in the SP/WSe₂/P(VDF-TrFE) FET device fabrication process. Then a step was created by scratching the layer penetrating down to the substrate. The thickness was finally determined by measuring the depth between the layer and the clean substrate, which was *ca.* 580 nm (Figure S13).

Cyclic Voltammetry (CV). The measurements were performed with a three-electrode configuration cell, with platinum working electrode, platinum wire as counter electrode, and saturated Calomel electrode as reference electrode. Ferrocene/ferrocenium redox couple was employed as internal standard. The SP was dissolved in acetonitrile at a concentration of 10⁻³ M, and the solution was degassed by bubbling nitrogen for 20 min. The scan rate during the CV experiments was kept at 100 mV/s.

ASSOCIATED CONTENT

Figures S1–S23, Table S1–S3, and references. Synthesis of silane-terminated SP derivative. SP SAM formation procedure. Fitting of MC → SP UV–vis absorption spectra. Dependence of saturation time for SP to MC transition on the UV illumination intensity. Water contact angle of unmodified Si/SiO₂ substrate, SP-treated Si/SiO₂ substrate as initial and after UV/heat treatment. AFM imaging of Si/SiO₂ substrate and SP-treated Si/SiO₂ substrate. PL mapping of SP/WSe₂. Characterization of SP/WSe₂ FET. Thickness measurement of the P(VDF-TrFE) layer. Optical microscopy images captured at four stages during the SP/WSe₂/P(VDF-TrFE) FET fabrication process. Character-

ization of SP/WSe₂/P(VDF-TrFE) FET in top-gate configuration. Characterization of SP/WSe₂/P(VDF-TrFE) FET in back-gate configuration. Energy level alignment between SP/MC and WSe₂. Hole transport modulation in SP/WSe₂ FET based on monolayer flake. Hysteresis characterization of FETs based on bare WSe₂, SP/WSe₂ and MC/WSe₂ under different scan rates and scan ranges. Comparison of SP/WSe₂ device performance before and after the curing step (PDF)

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Author Contributions

H.Q. and P.S. conceived the experiments and designed the study. A.G. designed and synthesized the spiropyran derivative. H.Q. performed the optical characterization, PL measurement, device fabrication, and characterization. S.I. carried out the AFM study and contributed to the interpretation of electrical characterizations. Z.L. performed the CV measurement. All authors discussed the results and contributed to the interpretation of data. H.Q. and P.S. cowrote the paper with input from all coauthors.

Notes

The authors declare no competing financial interest.

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